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### Search Results -

Terms	Documents
access\$3 same (DLL or (doubl\$2 near link\$3 near list\$1)) same (data near structur\$3) same (atomic\$4 near modify\$3)	0

Database:

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 US Patents Full-Text Database  
 US OCR Full-Text Database  
 EPO Abstracts Database  
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<u>Set Name</u>	<u>Query</u>	<u>Hit Count</u>	<u>Set Name</u> result set
side by side			
<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>			
<u>L4</u>	access\$3 same (DLL or (doubl\$2 near link\$3 near list\$1)) same (data near structur\$3) same (atomic\$4 near modify\$3)	0	<u>L4</u>
<u>L3</u>	access\$3 same (DLL or (doubly near link\$ near list\$1)) same (data near structur\$) same (atomic\$4 near modify\$3)	0	<u>L3</u>
<u>L2</u>	access\$3 same (DLL or ("doubly linked list")) same ("data structure") same ("atomically modify")	0	<u>L2</u>
<i>DB=USPT; PLUR=YES; OP=OR</i>			
<u>L1</u>	access\$3 same (DLL or ("doubly linked list")) same ("data structure") same ("atomically modify")	0	<u>L1</u>

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Search:

L2

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<i>DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR</i>			
<u>L2</u>	access\$3 same (DLL or ("doubly linked list")) same ("data structure") same ("atomically modify")	0	<u>L2</u>
<i>DB=USPT; PLUR=YES; OP=OR</i>			
<u>L1</u>	access\$3 same (DLL or ("doubly linked list")) same ("data structure") same ("atomically modify")	0	<u>L1</u>

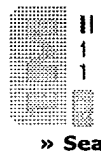
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( doubly linked list ) &lt;and&gt; access\* &lt;and&gt; atomic\*

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